

DEPARTMENT OF CHEMISTRY INDIAN INSTITUTE OF TECHNOLOGY MADRAS



Pre-requisites for AFM Imaging

AFM imaging requires that

- => Substrate should be clean.
- => The particles to be rigidly adhered to a substrate.
- => The particles to be dispersed on the substrate.
- => The substrate roughness should be less than the size of the nano-particles.

Ideal substrates for sampling

Sampling is the procedure to deposit the analyte on substrate which is a clean flat stable surface

Substrate types

- => Quartz.
- => Mica.
- => HOPG (Highly oriented pyrolytic graphite).
- => Si (100) (n/p type).
- => Au (1 1 1).

Ideal methods for sampling

- => Drop casting.
- => Spin coating.
- => Layer-by-layer method.

Note: After sampling user should do the overnight drying in vacuum and should preserve the sample in dust free environment. If your particle is not adhered to substrate, you can use adhesive materials like poly-lysine, Poly ethyleneimide, Aminopropyltriethoxysilane and make sure it's not detachable from substrate.

(Any common procedure other than the above has to be discussed with the operator)

Particles of maximum area 1 micron size,

Minimum area 100nm²

Height (/surface roughness) of sample 2-50nm can be analyzed.

Fees

AFM sample charges as follows

S. No	Category	Rate per sample (Rs)
1	Students from other department of IIT	1200/-
2	Students from other educational and research institutions	2000/-
3	Users from Industry	5000/-

Payments

- External users, please call and confirm the status of the instrument and then do RTGS for the appropriate amount and submit the acknowledgment slip with the sample.
- Please note that if the amount is not deposited it will not be possible to do analysis.

Banking details are given below

Contact

In-Charge AFM
Department of Chemistry, IIT Madras
Chennai 600 036.

Ph: 044-2257 5199

Email: cyoffice@.iitm.ac.in

Analysis Request Form (Internal) INDIAN INSTITUTE OF TECHNOLOGYMADRAS DEPARTMENT OF CHEMISTRY CHENNAI-36

Job Requisition form for AFM analysis

Name:	-	•		M.Sc/M.Tech/Ph.D/Project				
Department:				Email:				
Guide:				Tel:				
Sample Code	Sample typ	pe & Composition	Substrate	Imaging mode: (Contact/Non-Contact/conductive probe)				
Date			Sign	noture of Passagrah Supervisor				
			Sign	nature of Research Supervison				
For laboratory use								
DD. No. and Date		Date of submission		Completed on				

Analysis Request Form (External)

INDIAN INSTITUTE OF TECHNOLOGYMADRAS DEPARTMENT OF CHEMISTRY CHENNAI-36

	Job Re	equisition form fo	or AFM ar	nalysis	
Name:				M.Sc/M.Tech/Ph.D/Project	
Department:		Email:			
Guide:				Tel:	
			,		
Sample Code	Sample type & Composition		Substrate	E Imaging mode: (Contact/Non-Contact/conductive probe)	
Date			Sign	nature of Research Supervisor	
			J	1	
		For laborator	y use		
DD. No. and Date		Date of submission		Completed on	